

Search Notes

Application/Control No.

10/620,302

Examiner

German Viana Di Prisco

Applicant(s)/Patent under
Reexamination

GROVER ET AL.

Art Unit

2609

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT,EPO,JPO and IBM_TDB (see attached search strategy)	2/28/2007	GVDP
Inventor name and Assignee search in PALM ExPO and EAST	2/28/2007	GVDP
Consulted with Rafael Perez-Gutierrez and George Bugg	2/28/2007	GVDP
IEEE Xplore (http://ieeexplore.ieee.org/Xplore/DynWel.jsp)	2/28/2007	GVDP